

Notice of References Cited	Application/Control No. 10/538,613	Applicant(s)/Patent Under Reexamination DE VAAN, ADRIANUS JOHANNE	
	Examiner Christopher E. Mahoney	Art Unit 2851	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,626,411 A	05-1997	Takahashi et al.	353/94
*	B	US-2004/0141156 A1	07-2004	Beardsley et al.	353/069
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NON-PATENT DOCUMENTS

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